

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/773,440	FRADET ET AL.	
Examiner	Art Unit	
Sean E. Aeder, Ph.D.	1642	

	SEAR	SEARCHED		
Class	Subclass	Date	Examiner	
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INI	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
STN (MEDLINE, BIOSIS, EMBASE, SCISEARCH, DISSABS; attached), MEDLINE, WEST (PGPB, USPT, USOC, EPAB, JPAB, DWPI; attached)	3/14/2007	SEA
PALM inventor search	2/14/2007	SEA
STIC sequence search SEQ ID NO:1, 2, 3, 4, 9, 10, 13	2/14/2007	SEA